



ENERGY STAR® Program Requirements Product Specification for Data Center Storage

**Draft Test Method
Rev. January 2018**

1 OVERVIEW

The following test method shall be used for determining compliance with requirements in the ENERGY STAR Product Specification for Data Center Storage.

Note: EPA has removed an obsolete reference to the Power and Performance Data Sheet (PPDS).

2 APPLICABILITY

The following test method is applicable to all products eligible for certification under the ENERGY STAR Product Specification for Data Center Storage.

3 DEFINITIONS

Unless otherwise specified, all terms used in this document are consistent with the definitions in the ENERGY STAR Eligibility Criteria for Data Center Storage.

4 TEST SETUP

- A) Input Power: Input power shall be as specified in Table 1 and Table 2. The frequency for input power shall be as specified in Table 3.
- B) Ambient Temperature: Ambient temperature shall be no less than 18 °C and no greater than 28 °C over the duration of the test.
- C) Relative Humidity: Relative humidity shall be within 15% and 80%.

17 **Table 1: Input Power Requirements for Products with Nameplate Rated Power Less Than or Equal**
 18 **to 1500 W**

| Product Type | Supply Voltage | Voltage Tolerance | Maximum Total Harmonic Distortion |
|---|------------------------------|-------------------|-----------------------------------|
| Storage Products with Ac-Dc Single-Output PSUs | 230 volts (V) ac or 115 V ac | +/- 1.0 % | 2.0 % |
| Storage Products with Ac-Dc Multi-Output PSUs | 230V ac or 115V ac | | |
| Optional Testing Conditions For Ac-Dc Japanese Market | 100V ac | | |
| Three-phase Storage Products (North American Market) | 208V ac | | |
| Three-phase Storage Products (European Market) | 400V ac | | |

19 **Table 2: Input Power Requirements for Products with Nameplate Rated Power Greater Than**
 20 **1500 W**

| Product Type | Supply Voltage | Voltage Tolerance | Maximum Total Harmonic Distortion |
|---|------------------------------|-------------------|-----------------------------------|
| Storage Products with Ac-Dc Single-Output PSUs | 230 volts (V) ac or 115 V ac | +/- 5.0 % | 5.0 % |
| Storage Products with Ac-Dc Multi-Output PSUs | 230V ac or 115V ac | | |
| Optional Testing Conditions For Ac-Dc Japanese Market | 100V ac | | |
| Three-phase Storage Products (North American Market) | 208V ac | | |
| Three-phase Storage Products (European Market) | 400V ac | | |

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Table 3: Input Frequency Requirements for All Products

| Supply Voltage | Frequency | Frequency Tolerance |
|----------------|----------------|---------------------|
| 100 V ac | 50 or 60 Hz | ±1.0% |
| 115 V ac | 60 Hz | |
| 230 V ac | 50 Hz or 60 Hz | |
| Three-phase | 50 Hz or 60 Hz | |

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23 D) **Power Meter:** Power Meter(s) shall report true Root Mean Square (RMS) power and at least two
 24 of the following measurement units: voltage, current and power factor. Power Meter(s) shall
 25 possess the following attributes:

- 26 1) **Calibration:** The meter shall be calibrated within the past one year of the test date, by a
 27 standard traceable to National Institute of Science and Technology (USA) or a counterpart
 28 national metrology institute in other countries.
- 29 2) **Crest Factor:** An available current crest factor of 3 or more at its rated range value. For
 30 analyzers that do not specify the current crest factor, the analyzer must be capable of
 31 measuring an amperage spike of at least 3 times the maximum amperage measured during
 32 any 1 second sample.
- 33 3) **Minimum Frequency Response:** 3.0 kHz
- 34 4) **Minimum Resolution:**
- 35 i. 0.01 W for measurement values less than 10 W;
 - 36 ii. 0.1 W for measurement values from 10 W to 100 W; and
 - 37 iii. 1.0 W for measurement values greater than 100 W.
- 38 5) **Logging:** The reading rate supported by the meter shall be at least 1 set of measurements
 39 per second, where set is defined as watts. The data averaging interval of the analyzer shall
 40 equal the reading interval. Data averaging interval is defined as the time period over which all
 41 samples captured by the high-speed sampling electronics of the analyzer are averaged to
 42 provide the measurement set.
- 43 6) **Measurement Accuracy:** Measurement uncertainty as introduced by the instrument that
 44 measures the input power to the product under test, including any external shunts.
- 45 i. Power measurements with a value greater than or equal to 0.5 W shall be made with an
 46 uncertainty of less than or equal to 2% at the 95% confidence level.
 - 47 ii. Power measurements with a value less than 0.5 W shall be made with an uncertainty of
 48 less than or equal to 0.01 W at the 95% confidence level.

49 E) **Temperature Sensor:** The temperature sensor shall possess the following attributes:

- 50 1) **Logging:** The sensor shall have a minimum reading rate of 4 samples per minute.

51 2) Measurement Accuracy: Temperature must be measured no more than 50 mm in front of
52 (upwind of) the main airflow inlet of the UUT and reported by the sensor with an overall
53 accuracy of ± 0.5 °C or better.

54 5 TEST CONDUCT

55 5.1 Guidance for Implementation of SNIA Emerald™ Power Efficiency Measurement 56 Specification Version 3.0.1

57 A) Online 2 Data Center Storage products must include a RAID capable controller during all testing.

58
59 B) Storage products shipped with COMs must disable all COMs that are capable of being disabled
60 during the following tests:

61 1) SUT Pre-fill Test (7.3.2)

62 2) SUT Conditioning Test (7.3.3)

63 3) Block Access Active State Test (7.3.4, if applicable)

64 4) File Access Active Test (7.4, if applicable)

65 **Note:** EPA has added Section 7.4 to this list to address the new File I/O Active State Test option.
66 EPA has also revised the Section references to align with the updates labels in the Emerald Version
67 3.0.1 measurement specification.

68 5) Ready State Idle Test (7.5)

69 6) Following the completion of the Ready Idle State Test, COMs shipped with the storage
70 product shall be enabled and COM Validation Testing (7.6) shall be performed for all COMs
71 present in the product.

72
73 C) Products that are to be certified using Block I/O capability shall be tested using the Block I/O
74 Active State Test. Block I/O products with File I/O capability shall be tested under the following
75 additional requirements:

76 1) All usable Storage Devices shall be allocated to Block I/O for all testing with the exception of:

77 i. Storage Devices needed to enable a minimal File I/O capability in the system;

78 ii. Limitations imposed by the system for maximum allowable Block I/O capacity.

79 2) File I/O functionality shall be enabled during all testing.

80 3) No external File I/O storage requests shall be presented to a system during testing. (File I/O
81 functionality shall be in a Ready-Idle state).

82 D) Products that are to be certified using File I/O capability shall be tested using the File I/O Active
83 State Test.

84 **Note:** EPA has clarified that products may now test with either Block I/O or File I/O capability in
85 Version 1.1, but that products that are testing and certifying only with Block I/O, but that have File I/O
86 capability, still must follow the provisions in Section 5.1.C as laid out previously in Version 1.0.

87 **6 TEST PROCEDURES FOR ALL PRODUCTS**

88 **6.1 SUT Pre-fill Test**

89 The SUT pre-fill test shall be performed according to the SNIA Emerald™ Power Efficiency Measurement
90 Specification Version 3.0.1: *Section 7.3.2: Pre-fill Test.*

91 **6.2 SUT Conditioning Test**

92 The SUT conditioning shall be performed according to the SNIA Emerald™ Power Efficiency
93 Measurement Specification Version 3.0.1: *Section 7.3.3: Conditioning Test.*

94 **6.3 Block I/O Active State Test**

95 The Block I/O active state performance shall be measured according to the SNIA Emerald™ Power
96 Efficiency Measurement Specification Version 3.0.1: *Section 7.3.4: Block Access Online Active Test;* with
97 the additional guidance in Section 5 of this document.

98 **6.4 File I/O Active State Test**

99 The File I/O active state performance shall be measured according to the SNIA Emerald™ Power
100 Efficiency Measurement Specification Version 3.0.1: *Section 7.4: File Access Online and Near-Online*
101 *Active Test;* with the additional guidance in Section 5 of this document.
102

103 **Note:** EPA has added Section 6.4 to this list to incorporate the new File I/O Active State Test.

104 **6.5 Ready Idle State Test**

105 The Ready Idle state performance shall be measured according to the SNIA Emerald™ Power Efficiency
106 Measurement Specification Version 3.0.1: *Section 7.5: Block and File Access Ready Idle Test;* with the
107 additional guidance in Section 5 of this document.

108 **6.6 COM Validation Test**

109 The validation of COM functionality shall be recorded according to the SNIA Emerald™ Power Efficiency
110 Measurement Specification Version 3.0.1: *Section 7.6: Block and File Access Capacity Optimization Test;*
111 with the additional guidance in Section 5 of this document.
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- 113 A) Verification testing of COM features specified by the storage product shall be executed at least
114 once using storage devices of the vendor's choice. Once verified there is no requirement to re-
115 execute the verification testing procedure with different storage devices.
116